

Search Notes

Application/Control No.

10/601,475

Examiner

Elizabeth Ivey

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

1775

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See East Search	1/25/2006	EDI
Consulted Jennifer McNeil, Steve Stein, Tim Speer	1/24/2006	EDI